## DECOY STATE GENERATOR FOR QUANTUM KEY DISTRIBUTION SYSTEM



Project report

by

Eivind Sjøtun Simonsen

December 17, 2009

Supervisors: Post.doc. Vadim Makarov Prof. Johannes Skaar

NORWEGIAN UNIVERSITY OF SCIENCE AND TECHNOLOGY Department of Electronics and Telecommunications

### Problem description

Quantum key distribution (QKD) allows to securily exchange a secret key over an open optical channel. The key can subsequently be used to encrypt information, allowing for unconditionally secure communication.

The student will participate in building a fiber-optic QKD system. We use technologies developed for QKD over the last several years. Our main goal is to make our system free of all known security loopholes.

The student will work with a 1.55  $\mu$ m fiber-optic interferometric setup, high-speed electronics, and programmable controllers based on FPGA (Altera Stratix III). After the QKD system is completed (likely in 2010), experiments to demonstrate system performance and test its security are possible.

Assignment given: August 15, 2009 Supervisor: Vadim Makarov, IET & Johannes Skaar, IET

<sup>&</sup>lt;sup>0</sup>Front page picture originates from the cover of March 1998 issue of Physics World, cut from Ian Glendinning's website [5].

## Abstract

Cryptography has begun its journey into the field of quantum information theory. Classical cryptography has shown weaknesses, which may be exploited in the future, either by development in mathematics, or by quantum computers. *Quantum key distribution* (QKD) is a promising path for cryptography to enable secure communication in the future. Although the theory of QKD promises absolute security, the reality is that current quantum crypto systems have flaws in them, as perfect devices have proven impossible to build. However, this can be taken into account in security proofs to ensure security, even with flaws.

Security loopholes in QKD systems are being discovered as development progresses. Nevertheless, the system being built at NTNU is intended address them all, creating a totally secure system. This report describes the construction of the light source for a QKD system. The laser in the light source allows an attack called the *photon number splitting* attack. Countermeasures for this loophole will be done by using a *decoy state* method. This is dependent on the pulses being of varying intensity and is realized by using an intensity modulator.

Experiments were done with the laser and intensity modulator in order to characterize their properties, and create the electonic circuits required for them to work. The intensity modulator needed to be biased permanently with a battery powered circuit. The laser driver needed to be tuned for the laser to output the required 100 ps pulses. The laser peration was characterized in the time and wavelength domains.

The light source and electronics were mounted into the sender's rack case, called Alice. Together with her counterpart Bob, they will form a complete QKD system, hopefully leaving the evil Eve unable to hack it.

# Contents

A	bstra	ct v
Li	st of	figures ix
Li	st of	tables x
1	Intr	oduction 1
	1.1	State of cryptography today
	1.2	Motivation
	1.3	This project
<b>2</b>	The	ory 5
	2.1	How quantum key distribution works
	2.2	This implementation
		2.2.1 Photon number splitting attack
		2.2.2 Decoy states
	2.3	System structure
		2.3.1 Tour of the system from photon's point of view
3	Syst	tem components 11
	3.1	Overview
	3.2	Laser
		3.2.1 Pulsed laser driver $\ldots \ldots 14$
		3.2.2 Laser temperature stabilization
	3.3	Intensity modulator
		3.3.1 Biasing circuit
4	Rac	k case assembly 19
<b>5</b>	Exp	erimental work 25
	5.1	Equipment
	5.2	Intensity modulator
		5.2.1 Drift of minimum transmittance bias voltage
		5.2.2 Temperature dependent drifts
	5.3	Laser

6	Conclusion and further work	35													
Aj	Appendices														
$\mathbf{A}$	Calculations	<b>37</b>													
	A.1 Derivation of deviation in transmittance for small bias deviation	37													
	A.2 Laser bandwidth	38													
в	Circuit designs and drawings	39													
	B.1 Laser driver	39													
	B.2 Thermoelectric controller	40													
	B.3 Power	41													
$\mathbf{C}$	Datasheets	43													
	C.1 Intensity modulator	44													
	C.2 Laser	49													
	C.3 Buffer IC	57													

#### References

67

# List of figures

2.1	Planned structure of the QKD system	9
3.1	Electronic system of decoy state generator	2
3.2	Optical system of decoy state generator	2
3.3	Transient laser oscillations	3
3.4		4
3.5		5
3.6		6
3.7		7
4.1	Alice's rack case. Front side viewed, with electronics shown	0
4.2		1
4.3		2
4.4		3
5.1	Intensity modulator minimum $V_{bias}$ drift $\ldots \ldots \ldots \ldots \ldots \ldots \ldots \ldots \ldots 2$	7
5.2		7
5.3		8
5.4		8
5.5		1
5.6		1
5.7		2
5.8	· / · · /	2
5.9		3
5.10		3
5.11		4
5.12	±	4
B.1	Laser driver	9
B.2		9
B.3	Thermoelectric controller	0
B.4		1

# List of tables

B.1	TEC-limits			•					•		•	•	•	•	•	•	•		•	•	40
B.2	TEC resistor values										•	•			•	•	•		•		40
B.3	Power distribution							•		•	•	•	•		•	•	•		•		41

## Introduction

Alice and  $Bob^1$  have the need to speak with each other secretly without  $Eve^2$  picking up the message. This calls for the message to be encrypted so that only Bob and Alice knows what the message is, while Eve, unable to decrypt it, is left in the dark.

### **1.1** State of cryptography today<sup>3</sup>

There are two ways of encrypting messages sent between Alice and Bob. The most secure way is by using symmetric ciphers. Here both Alice and Bob share the same key and can encrypt and decrypt messages with it. The problem with this method is sending this key between them. This is why asymmetric ciphers are used. When Alice wants to share something with Bob securely without having a secure key or a way to distribute it, Alice asks Bob to give her a *public key*. This key is made in such a way that it can only encrypt messages, while Bob keeps a *private key* secretly which he can use to decrypt the message. To generate the public key Bob uses ideally a one-way function to calculate it from the private key. This way one can make a public key based on the private key, but not obtain the private key from the public key. And this is the core: All current functions are possible to reverse. The security is based on the time it takes to reverse it, which is exponential using known algorithms on a classical computer. It is said to be *computationally secure*. This means that if you have a long enough key it could take the lifetime of the universe to crack it. Of course, at the end of existence, cracking a key is probably not our main concern. So unless there is a faster way to do this, current asymmetric ciphers are secure. Also the non-existence of algorithms which would crack a key in less than exponential time, is yet to be proven.

But there is a faster way. Using the laws of quantum physics there are suggested algorithms

 $<sup>^1\</sup>mathrm{Alice}$  and Bob are the standard names for sender and receiver for secure communication in cryptography.

 $<sup>^2\</sup>mathrm{Eve}$  is the standard name for eavesdropper.

<sup>&</sup>lt;sup>3</sup>For a broader discussion see [4], which my discussion is partially based on.

which could crack at least the common asymmetric encryptions (such as  $RSA^4$  [14]) using only polynomial time [16], i.e. within reasonable time. This however requires the construction of a *quantum computer*. Currently there are only suggested ways of doing quantum computation, but nobody knows how to make a large scale computer, or if it is possible at all. In addition, there exists asymmetric encryption (e.g. McEliece cryptosystem [11]) which even a quantum computer may use exponential time to crack [2]. This is still to be proven.

### 1.2 Motivation

The obvious reason for studying quantum cryptography is that if today's cryptography is cracked, either by mathematicians or by quantum computers, *quantum cryptography* already in place has that problem sorted out. According to the theory of quantum cryptography it is possible to make uncrackable key distribution. This is also what quantum cryptography in reality is; key sharing. The cryptography is still classical, using symmetric ciphers, but the problem of distributing the key is solved using quantum physics. Hence the term *quantum key distribution* (QKD), which is more accurate.

Why is secure communication important? For the military the reasons are obvious; Alice and Bob being allies, while Eve being the enemy. Other reasons may be commercial or governmental secrets. However, the most obvious reasons for us are money and privacy. Privacy because certain things we think or do, can be abused if such information falls into the wrong hands. When it comes to economy, if the banks are cracked, it could lead to malicious persons not only stealing money, but creating them from nothing. Stealing money would be a huge problem itself, but if one produces more money, the value of them decreases. This could lead to a tremendous inflation, and the world economy could collapse. Hence, QKD could potentially save the world!

As the other extreme, it could turn out that current encryption is proven computationally secure and building quantum computers proves to be impossible. This would not mean that the research was all a waste. Since quantum physics is not completely explored, one can still learn much about Nature and techniques which may be usable for other purposes. And, if current cryptography is cracked, dare we wait until then to develop a secure system? If we wait all previously recorded communication could be cracked retroactively and secret information leaked. Therefore we need to be prepared in advance, in case of this event.

 $<sup>{}^{4}</sup>$ RSA is a public-key encryption based on the exponential time it takes for classical computers to factorize large prime numbers. It is named after it's inventors Rivest, Shamir, and Adleman [14].

### 1.3 This project

To do everything which is described in the problem description, is out of the scope of a half time one semester project. The scope is to do a part of it. Previous work was done by Ulianov [17]. He constructed a laser driver and started work with the FPGA<sup>5</sup> and DAC<sup>6</sup>. When I came into the project, my task was to start the assembly of the system. As we are two student working on the project, it is split in two parts. Ole Christian Tvedt worked with FPGA and DAC to control the system, while I assembled the system. The part I assembled was most of the electronics (including FPGA, DAC and laser driver), and parts of the optics, in Alice.

The QKD system has the goal of addressing all known loopholes. A laser is the common photon source in such systems. As will be explained in section 2.2.1, the fact that it is not a true single photon source, opens the possibility for what is called a *photon number* splitting (PNS) attack. One way to expose such attack is by using decoy states as explained in section 2.2.2. This implementation requires the possibility to control the output pulse energy of Alice, which is why she has an intensity modulator.

These components, including the electronics to control them, was mounted in aluminum casing.<sup>7</sup> When the system is complete, it will be used for various QKD experiments. The part described in this project is the decoy state generator in Alice.

<sup>&</sup>lt;sup>5</sup>FPGA - Field-Programmable Gate Array

<sup>&</sup>lt;sup>6</sup>DAC - Digital to Analog Converter

<sup>&</sup>lt;sup>7</sup>Feel free to peek at pages 20 to 23 to see pictures.

## Theory

This chapter describes the basic theory behind QKD and a possible attack which affects the system design. Component-specific theory is explained in the next chapter.

### 2.1 How quantum key distribution works

Quantum cryptography promises unconditional<sup>1</sup> security. This security is dependent on the key and the key distribution system. In 1917, Gilbert Vernam invented the *One-time* pad [19]. It encrypts the message using XOR operation<sup>2</sup> on the message and a random symmetric key. If the key is at least as long as the message, and only used once, it is impossible to crack. This is true, as long as Eve does not have a copy of the key. With a classical communication channel it is possible for Eve to obtain a copy of the key without Alice and Bob knowing about it. This is where QKD comes in to play. Based on the no cloning theorem<sup>3</sup> of physics, Eve is unable to copy a key, sent between Alice and Bob, without them noticing. There are different ways of realizing this. The following explanation is based on the *Bennett-Brassard 1984* (BB84) protocol.

In 1984, Charles Bennett and Gilles Brassard proposed a protocol for distributing a key securely through a quantum channel [1]. Information sent through a quantum channel is encoded as *qubits*. Qubits (quantum bits) are the quantum equivalent of the classical bits. The difference is, while bits are either 0 or 1, qubits can be a superposition of these two, with notation  $|0\rangle$  and  $|1\rangle$  respectively. The superposition is described by

$$|\psi\rangle = a \left|0\right\rangle + b \left|1\right\rangle \tag{2.1}$$

where  $a, b \in \mathbb{C}$  and  $|a|^2 + |b|^2 = 1$ .  $|0\rangle$  and  $|1\rangle$  are orthogonal quantum physical states, meaning that their wave functions are orthogonal. When measuring, the only possible outcome is one of the orthogonal states in the basis of the measuring operator.<sup>4</sup> After

<sup>&</sup>lt;sup>1</sup>Unbreakable even with no limit on computational power.

<sup>&</sup>lt;sup>2</sup>XOR - eXlcusive OR: adds the message and key modulo 2. (0 + 0 = 1 + 1 = 0, 0 + 1 = 1 + 0 = 1).

<sup>&</sup>lt;sup>3</sup>It is impossible to copy an arbitrary unknown quantum state [20].

<sup>&</sup>lt;sup>4</sup>A measuring operator is a matrix describing the physical measuring operation.

the measurement the qubit is left in that state. In the case of photons, they are usually destroyed.

Qubits can be represented in many ways. The BB84 protocol [1] uses polarized light as qubits. The photons are sent with one of four different polarizations (states); 0°, 45°, 90° and 135°. The two first polarizations correspond to the 0 bit and the latter two to 1 bit. 0° and 90° is called the + basis, while 45° and 135° is called the × basis. Now each basis consists of two orthogonal polarizations;  $|0_+\rangle$  and  $|1_+\rangle$ , and  $|0_\times\rangle$  and  $|1_\times\rangle$ . If Alice sends a qubit, say  $|0_+\rangle$  (0 in + basis), and Bob measures the qubit in the same basis, he measures 0. Now if he instead tries to measure it in the × basis, the incoming photon, which is 0° polarized, is a superposition of the two polarizations of this basis.

$$|0_{+}\rangle = \frac{1}{\sqrt{2}} |0_{\times}\rangle - \frac{1}{\sqrt{2}} |1_{\times}\rangle \tag{2.2}$$

This gives a 50/50 percent chance for the photon to be measured as 0 or 1. Eve must not know in advance which basis Alice and Bob chooses, because then she could always choose the right basis, measure the photon and resend it in the same state to Bob. For this reason Alice and Bob do not know which basis the other has chosen. The basis choice should not be possible to predict by Eve, hence it is randomly selected. Both Alice and Bob choose basis at complete random, so there is only 50% chance of them choosing the same basis. After the key is sent, Alice and Bob anounce on a public channel which basis they chose without sharing which bit values were sent or recieved. They keep the bits where they have the same basis, and discard the rest. They now share the same secret key.

Now, if Eve puts herself in between Alice and Bob, there are numerous things she can do to try and gain information about the key.<sup>5</sup> One way is to intercept the photons, and resend them. Choosing to measure in the same two bases as Alice and Bob, she also has 50% chance of choosing the right basis. Since the measurement destroys the photons, she has to resend all photons recieved. These bits are sent with a basis which has a 50% chance of being the same as Alice's. If we look only at the photons which are not discarded by Alice and Bob, 50% of these photons will be in the wrong basis. This causes Bob to measure the wrong bit value, with 50% chance. 25% of the bits Alice and Bob choose to keep will then have different values. Hence, Eve introduces a *quantum bit error rate* (QBER) of 25%. So, if Alice and Bob measure too much QBER, they know Eve is eavesdropping, and will abort communication.

### 2.2 This implementation

In the system being built, the goal is to address all known loopholes. The part which was built for this report, implements an intensity modulator to be able to control the energy/photon number of laser pulses. This is to tackle an attack called *photon number* splitting (PNS) attack [6, 3] with a *decoy state* method [7, 9, 8].

<sup>&</sup>lt;sup>5</sup>A review of different attacks can be found in [18].

#### 2.2.1 Photon number splitting attack

Today's QKD systems do not use true single photon sources, as they are still in the development stage. Instead a laser attenuated to have a mean photon number per pulse  $\overline{n} < 1$ , is used. It obeys the Poisson distribution [15, p. 463-464] with expectancy value  $\mu = \overline{n}$ . This imperfection makes an opening for an attack, namely the *photon number splitting* attack [6, 3]. Some of the pulses will contain more than one photon. If Eve intercepts communication, she could keep one of these photons and store it until Alice and Bob announce which bases they used. Then Eve could measure the photon in the correct basis and obtain the correct key value. The pulses containing only one photon she simply blocks so they are counted as loss by Alice and Bob. This high loss can reveal an attack. To compensate, Eve is considered to use a lossless channel for the photons she sends to Bob. This way Eve can obtain full key information, without them knowing.

#### 2.2.2 Decoy states

A proper way of handling this attack is by using *decoy states* [7]. It is based on the fact that Eve will always keep/block one photon as long as at least one is present. Alice and Bob do QKD with BB84 using  $\mu < 1$ . Randomly and intentionally, Alice sends decoy states with  $\mu' \geq 1$  with a certain probability. These pulses will then often have multiple photons. As they are random, Eve has no way of knowing which pulses are signal, and which are decoy. However, the weaker signal pulse is more likely to contain only one photon, and is therefore more likely to be blocked. This gives different yield (or transmittance) for the decoy and signal pulses. After a sequence, Alice announces publicly which pulses were decoy states. By public discussion with Bob, they estimate the yield for both the BB84 signal and the decoy. If Eve is not interfering, they should be equal. If however, the decoy pulses have a much higher yield than the signal, they know Eve is snapping up photons and they abort communication. To simplify; by measuring the photon number statistics, a PNS attack can be discovered.

This idea was modified and optimized by [9, 8]. They suggest a *two decoy state* with two weak decoy states (weak+vacuum)  $v_1$  and  $v_2$ . This method is very close to the performance of an asymptotic decoy method using infinite number of decoy states, which gives maximum key generation rate but is more difficult to implement. The photon numbers of the decoy states and the signal state are bounded by

$$\begin{array}{l}
0 \le v_2 \le v_1, \\
v_1 + v_2 < \mu, \\
\mu \in (0, 1].
\end{array}$$
(2.3)

The optimum values of these parameters are dependent on implementation, and vary with line loss and thus transmission distance.

### 2.3 System structure

Instead of orthogonal polarizations as bases as explained in section 2.1, orthogonal phase is used. This is to eliminate the effect of the drift in polarization, caused by slight random imperfections and uncontrollable strains in the fiber-optic transmission line, changing over time [15, p. 341]. However, there will be a phase drift in the interferometer, caused by temperature dependencies. But this is easier to control and track as it is inside Alice and Bob [10].

The system setup (Figure 2.1) was designed by *The Quantum Hacking group*, and is based on previous systems and advances in theory. This system is an updated version of that which Vadim Makarov used in his PhD thesis [10]. The goal is to build a working system which is unhackable by all current methods.

The part of the system which is treated in this project is the *laser*, *intensity modulator* and *linear polarizer*. These were tested and mounted, in addition to connecting FPGA and DAC. Also, a few electronic circuits (power supplies, etc.) were made and mounted, as they were required for the components to work. These components will be explained in the next chapter.

#### 2.3.1 Tour of the system from photon's point of view

We begin at the upper right corner of figure 2.1. A short laser pulse is created by the 1.55  $\mu$ m laser, its intensity is adjusted by a Mach-Zehnder intensity modulator. The pulse is polarized by a linear polarizer. The pulse then goes through the interferometer, starting with a 50/50 beam splitter. Half the pulse is sent through unaffected, while the other is modulated by the phase modulator. This modulator decides the basis and bit value of the output photon. (A variable time delay ensures that the two pulses reach the last beam splitter down at Bob at the same time, interfering fully when Alice and Bob select matching bases.) Before leaving Alice, they are attenuated to single photon level.

If the photon is not lost during transmission, Bob now receives it. It goes through a polarization controller which counteracts the polarization change by the line. Bob has an interferometer, equal to Alice's, which chooses a basis to measure in. At the end two single photon detectors (SPDs), corresponding to values '0' and '1', do the final measurement.

The 1.3  $\mu$ m laser is used to send a clock signal from Alice to Bob for them to be in sync. It is multiplexed into the same fiber as the signal by the WDM.<sup>6</sup> This is mainly for long distance QKD, as the clock can be sent directly if Alice and Bob are in the same room during initial experiments. The FPGAs control the hardware while the PCs do all public communication needed to settle on a key, encrypt, send and decrypt messages.

<sup>&</sup>lt;sup>6</sup>WDM - Wavelength-Division Multiplexing.

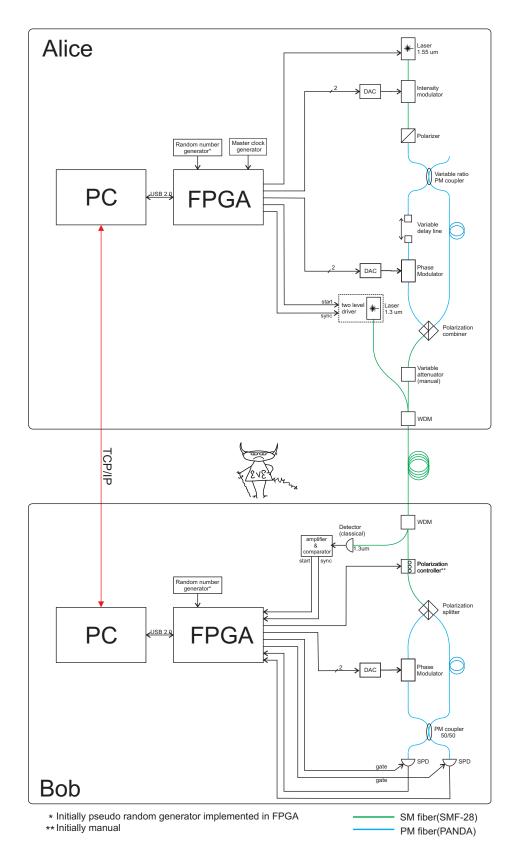


Figure 2.1: Planned structure of the QKD system This is the design draft which is the starting point of the system. It was drawn by Ulianov [17].

## System components

This chapter describes all components of the QKD system constructed during this project. The main purpose of this system is to be secure. Key generation rate and transmission distance are secondary, but not irrelevant. High speed electronic and electro-optic components were used, but within a suitable price range.

#### 3.1 Overview

Alice and Bob are built into 19" aluminum rack boxes. Alice's box is anodized red, and Bob's box is blue.

Figure 3.1 shows the system schematic of the electronics. The FPGA is programmed to control the active components of the system. It sends a 200 MHz clock through the Bitec HSM prototype board to the laser driver. The laser, laser driver and TEC<sup>1</sup> are explained in section 3.2. The FPGA is also connected to the DAC, which is not yet configured and tested, nor mounted. The DAC's purpose is to control the intensity modulator. This is done by applying voltages of different values corresponding to the different signal and decoy states. The intensity modulator is explained in section 3.3. The FPGA and DAC boards will not be explained in detail as they are not a part of my project.

Figure 3.2 shows the optical schematic. The laser light, which is mostly linearly polarized, is sent through a linear polarizer, oriented with a rotatable connector for maximum transmission. It then goes through the intensity modulator which varies the intensity according to the input signal voltage. Between all the components single mode (SM) fiber is used.<sup>2</sup> After the linear polarizer the fibers are also polarization maintaining (PM). This is to keep track of the polarization, and keep the light polarized. There is also one connector between all components, contributing to loss.

<sup>&</sup>lt;sup>1</sup>TEC -Thermo-Electric Controller.

 $<sup>^{2}</sup>$ Since the system relies on short pulses, it uses SM fibers as they does not widen the pulse as much as multimode fibers, and they keep the polarization well defined [15, p. 340-341].

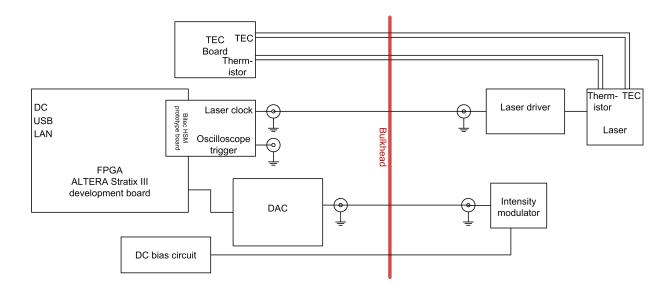


Figure 3.1: Electronic system of decoy state generator

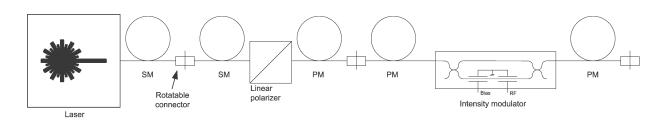


Figure 3.2: Optical system of decoy state generator

### 3.2 Laser

The laser is the source of the photon pulses.<sup>3</sup> The photons need to be localized in time for the modulators to be able control the intensity and phase. They also need to be sufficiently separated for Bob to distinguish them and receive the correct key. Hence, the laser has to be pulsed at short pulse lengths.

The laser used is Eudyna FLD5F15CX-E (appendix C.2). It is a 1550 nm laser, which is the wavelength which has minimum loss in silica glass fibers [15, p. 350]. This is important since we want as many photons as possible to reach Bob. The laser also has the capability to measure and regulate its temperature, using an external controller (see section 3.2.2). This laser was chosen as it has a single longitudinal mode, and thus a single wavelength. This is true as long as the temperature is kept constant. This will be important when adding narrowband components to the system, such the WDM shown in figure 2.1.

When the laser is turned on it overshoots the steady state intensity, and oscillates around it before it settles as seen in figure 3.3. The idea is to power the laser to create the first over-swing, and then cut the power to turn it off. To do this a *Step Recovery Diode* (SRD) is used. It has the ability to switch off the current going through very rapidly, shutting the laser off sufficiently fast [17]. Shutting the pulse off before it has done a full oscillation, makes the pulse shorter and weaker. In this system a weak pulse should not present a problem, as Alice's output will be on a single photon level. Still it has to be strong enough to compensate for all losses in processing the pulse.

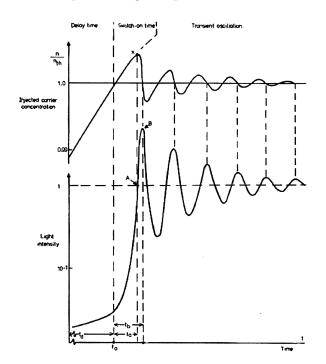


Figure 3.3: Transient laser oscillations. Cut from [17].

<sup>&</sup>lt;sup>3</sup>For laser physics see [15, p. 532-620].

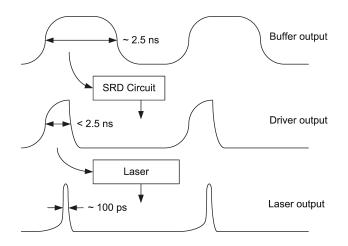


Figure 3.4: Time diagrams of laser driver

#### 3.2.1 Pulsed laser driver

To create photons which are localized in time, short laser pulses are needed. For this system, the laser will produce pulses of 100 ps.<sup>4</sup> Driving the laser is a 200 MHz digital signal. This has 2.5 ns long on-periods. A circuit (figure B.1) with a SRD was built by Ulianov [17]. The circuit powers the first period of the laser oscillation, then cuts the power and resets during the off-period (see figure 3.4). The clock signal from the FPGA is impedance matched to 50  $\Omega$ . It cannot drive the low-impedance laser by it self, hence a buffer (figure B.2) to amplify the signal and power the SRD circuit is used.

#### 3.2.2 Laser temperature stabilization

The laser's temperature is regulated by a thermoelectric unit, built into the laser package. It heats or cools the laser depending on the polarity of the input voltage. To control this a MAX1968 temperature controller evaluation kit was used. It has the capability of controlling the set point of temperature wanted in the laser. Appendix B.2 describes the parameters set for the circuit. Figure B.3 shows a connection diagram, while table B.1 shows the parameters set. Table B.2 shows resistor values for those which had to be exchanged to get these parameters.

### **3.3** Intensity modulator

To create the decoy states an intensity modulator is needed to control the levels of  $\mu$ ,  $v_1$  and  $v_2$ , corresponding to the signal state, weak state and vacuum state, respectively. The intensity modulator is an electro-optic modulator.<sup>5</sup> It is a small Mach-Zehnder interfer-

<sup>&</sup>lt;sup>4</sup>Pulses are measured at *full width half maximum* (FWHM).

<sup>&</sup>lt;sup>5</sup>For the basics of how electro-optic modulators work, see [15, p. 838-842].

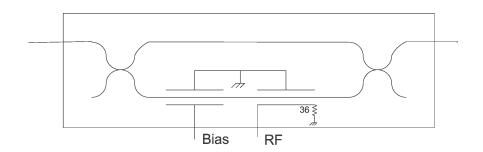


Figure 3.5: Mach-Zehnder intensity modulator

ometer, built on a lithium niobate die, which varies the optical length in one branch by applying an electric field to to a section of it (see figure 3.5). This section has a voltage dependent refractive index, which creates voltage dependent interference between the two branches, and thus a voltage dependent transmittance.

The intensity modulator used is SDL IOAP-MOD 9082 (appendix C.1). It has two inputs; one bias input to set a working point, and one radio frequency (RF) input for the signal. The bias input is a capacitive circuit, so it does not draw any current. The RF signal needs to be impedance matched to cope with high frequencies. The RF input is impedance matched to the waveguide impedance, which is 36  $\Omega$ . The RF signal however goes though 50  $\Omega$  coaxial cable, so a resistor of 15  $\Omega$  was set in series, see figure 3.7. Since it is a resistive circuit in the intensity modulator, it will dissipate heat which could lead to a drift in intensity, hence it should have low average power. Therefore the signal will only be on when a pulse is expected. To compensate for possible voltage dependent drift, the signal will average at zero. So the RF signal should be zero most of the time, and alternate polarity when modifying laser pulses. Hence, the intensity modulator needs to biased to the minimum transmittance voltage ( $V_{bias} = V_{Tmin}$ ), in order to have minimum with no signal on the RF input.

The transmittance  $\mathcal{T}$  of the intensity modulator depends on the voltage as a function the input voltage V [15, p. 840-841]:

$$\mathcal{T}(V) = \cos^2\left(\frac{\varphi_0}{2} - \frac{\pi}{2}\frac{V}{V_{\pi}}\right)$$
(3.1)

where  $\varphi_0$  is a device dependent offset. As the intensity modulator has two inputs, corresponding to different sections of the modulation branch, there will be different  $V_{\pi}$  for the inputs. Setting  $V_{\pi}$  for the RF input, and  $V_{b\pi}$  for the bias input, we get

$$\mathcal{T}(V_{bias}, V_{RF}) = \cos^2\left(\frac{\varphi_0}{2} - \frac{\pi}{2}\frac{V_{bias}}{V_{b\pi}} - \frac{\pi}{2}\frac{V_{RF}}{V_{\pi}}\right).$$
(3.2)

The passive state of the intensity modulator (no RF signal input) is set to off;  $\mathcal{T}(V_{bias}, 0) = \mathcal{T}(V_{\mathcal{T}min}, 0) = 0$ . Hence,

$$\frac{\varphi_0}{2} - \frac{\pi}{2} \frac{V_{\mathcal{T}min}}{V_{b\pi}} = \frac{\pi}{2}$$
(3.3)

When the intensity modulator is biased at this value  $(V_{bias} = V_{Tmin})$ , we get

$$\mathcal{T}_{RF}(V_{RF}) = \cos^2\left(\frac{\pi}{2} + \frac{\pi}{2}\frac{V_{RF}}{V_{\pi}}\right) = \sin^2\left(\frac{\pi}{2}\frac{V_{RF}}{V_{\pi}}\right)$$
(3.4)

Notice that  $\mathcal{T}_{RF}(V_{RF}) = \mathcal{T}_{RF}(-V_{RF})$  and  $\mathcal{T}(V_{RF} = V_{\pi}) = 1$ . This is valid as long as  $V_{\mathcal{T}min}$  does not drift. If  $V_{bias}$  is shifted by a distance  $\Delta V$  relative to  $V_{\mathcal{T}min}$ , then we get  $\mathcal{T}_{RF}(V_{RF}) \neq \mathcal{T}_{RF}(-V_{RF})$ . Also notice that  $\frac{d\mathcal{T}_{RF}}{dV_{RF}}$  has its maximum at  $V_{RF} = \pm \frac{1}{2}V_{\pi}$ . Setting this value for  $V_{RF}$  and  $V_{bias} = V_{\mathcal{T}min} + \Delta V$ , we get (see appendix A.1)

$$\mathcal{T}_{\pm}(\Delta V) = \frac{1}{2} \pm \Delta \mathcal{T}(\Delta V) \approx \frac{1}{2} \pm \frac{\pi}{2} \frac{\Delta V}{V_{b\pi}}$$
(3.5)

where  $\mathcal{T}_{\pm}$  corresponds to  $V_{RF} = \pm \frac{1}{2} V_{\pi}$ . Figure 3.6 shows this graphically. This will be important in measuring and setting  $V_{bias}$  in section 5.2.1. A drift in  $V_{\mathcal{T}min}$  is expected as it is common in such modulators [12]. Short term drift is caused by pyroelectric and piezoelectric characteristics of the ferroelectric lithium niobate. Charges in the crystal are attracted to surface of it, affecting the electro-optic effect. Long term drift is caused by oxide properties of the the buffer layer between the electrodes and the lithium niobate, and its interface to the latter.

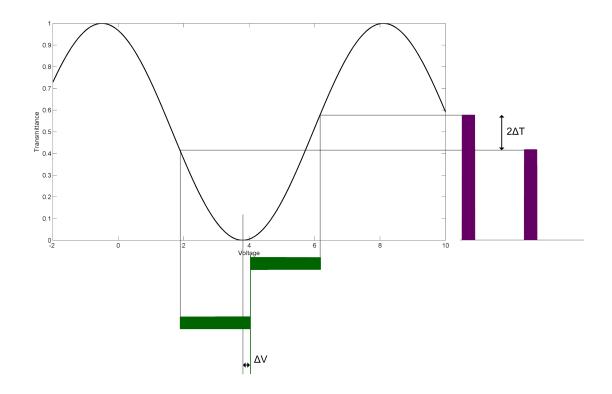


Figure 3.6: Transmittance of intensity modulator.  $\Delta V$  is the bias offset.  $\Delta T$  is the corresponding offset in transmittance. This is an ideal curve. In reality the transmittance never reaches zero.

#### 3.3.1 Biasing circuit

As it turned out (see section 5.2),  $V_{\mathcal{T}min}$  drifted after setting it. Fortunately it stabilized after several hours. This motivated the construction of a permanent bias circuit. For this two large (CR2450) 3V lithium batteries were used. These batteries have flat voltage/time curves which means that it does not have to be adjusted often. The batteries were connected in series with a voltage divider of 1470 $K\Omega$ . With a capacity of 550mAh this should give a lifetime of up to 15 years.<sup>6</sup>



Figure 3.7: Intensity modulator biasing circuit

 $<sup>^6\# \</sup>rm hours{=}(550mAh)/(6V/1470K\Omega).$  Self-discharge of button lithium batteries is almost negligible, but it could lower the lifetime somewhat.

## Rack case assembly

The components were mounted to Alice's red anodized aluminum bulkhead as seen in figures 4.1 to 4.4 on the following pages.<sup>1</sup> The placement of circuit board's holes was transferred to the bulkhead. The holes were drilled and tapped for screws to fasten. Required power supplies, and such, were constructed and cables connected. The circuit board were marked with their designed properties, and also the cables, to make it easier to fix and modify the system.

After the experiments on the intensity modulator, it was mounted. The biasing circuit was placed on the other side of the bulkhead, together with the other electronics.

The laser, with buffer and driver, was mounted by Ulianov [17] on a breadboard. It needed to be moved to the bulkhead. This caused some problems as it had to be removed from the breadboard and resoldered. However, this was fixed so the laser worked properly. As we can see in the datasheet (appendic C.2) the laser modulation voltage is negative, relative to its casing ground. The laser driver outputs only positive voltage. Hence, the ground output of it had to be connected to modulation, and the positive to laser ground. Therefore the laser package needed to be isolated from ground. Hence, its casing needed to be separated from the bulkhead. This was done by using a thermally conducting, electrically isolating silicone sheet, and nylon screws.

 $<sup>^1\</sup>mathrm{The}$  DAC seen in figure 4.3 was, unfortunately, not made to work. It had to be replaced with another model.



Figure 4.1: Alice's rack case. Front side viewed, with electronics shown.



Figure 4.2: Alice's rack case. Back side view, with optics shown.



Figure 4.3: Electronic side of the bulkhead



Figure 4.4: Optic side of the bulkhead

## **Experimental work**

This chapter describes the working process chronologically with focus on measurements and results which affected the design.

### 5.1 Equipment

- Digital Oscilloscope (DO) Tektronix TDS7104 (SN: B020503)
- Sampling Oscilloscope (SO) Tektronix 7854 (SN: 050-1650-01)
- Optical Spectrum Analyzer (OSA) Hewlett-Packard 86142A (SN: US38380263)
- Signal Generator Hewlett-Packard 33120 (SN: US36031913)

### 5.2 Intensity modulator

The intensity modulator<sup>1</sup> has an RF-input and a bias input. The RF-input is to be fed by a signal from the DAC which changes to a new voltage every 5 ns, corresponding to the 200 MHz bitrate of the system. To prevent intensity drift, the signal will alternate between positive and negative voltage, averaging the variations to zero. During the off-periods of the RF-signal the intensity modulator is set to minimum transmission. This is done with the bias input. The bias  $(V_{bias})$  input should be equal the voltage corresponding to minimum transmission  $(V_{\tau min})$ . The latter was tested for stability in two ways; *time* and *temperature* dependent drift. Extinction ratio of the intensity modulator was measured to be 32 dB.

<sup>&</sup>lt;sup>1</sup>See figure 3.7 in 3.3 and appendix C.1

#### 5.2.1 Drift of minimum transmittance bias voltage

#### Method

The laser was running in continuous mode with an output intensity of 2.0 mW. The bias  $V_{bias}$  was adjusted to  $V_{\mathcal{T}min}$ , corresponding to minimum transmittance. After a period of time,  $V_{bias}$  was readjusted to  $V_{\mathcal{T}min}$ . In other words, tracking  $V_{\mathcal{T}min}$  by adjusting the bias manually from time to time. This was first done using an optical power meter to measure the transmitted intensity while tuning to get to minimum.

For the second long test a more accurate method was used. While the intensity modulator was biased, a signal with short duty cycle square pulses was put on the RF input. The pulses alternated the polarity every other pulse, with constant amplitude. From equation (3.4) we see that only the amplitude (not the polarity) affects the transmittance, when the mmodulator is biased properly. However, by equation (3.5) we see that if the bias is offset by  $\Delta V$  when  $V_{RF} = \pm \frac{1}{2} V_{\pi}$ , there will be a polarity dependent difference in transmittance.

The signal generator was used to generate the signal alternating between  $+\frac{1}{2}V_{\pi}$  and  $-\frac{1}{2}V_{\pi}$ , following the form of the bars in the bottom of figure 3.6. Here, the signal generator's wave function was set to have the period divided into 400 points, whereas points 0-10 was set to +1 and 200-210 to -1, the rest to 0. The frequency was set to 100 kHz. While the laser was running in continuous mode, the output was measured using the DO. The output intensity would then look something like the bars to the right in figure 3.6. The bias was then tuned so subsequent pulses were at the same level, as seen in figure 5.3. The new value of  $V_{\tau min}$  was then noted.

#### **Results and discussion**

Figure 5.1 shows that there is a drift in  $V_{\mathcal{T}min}$ . It also shows that it was difficult find the exact minimum with the first method, as the transmittance never goes to zero. This motivated a longer test and more accurate test. Figure 5.2 show that after a long time it stabilizes. There is some "oscillations" on the graph. This is because varying the voltage beyond  $V_{\mathcal{T}min}$  altered the new  $V_{\mathcal{T}min}$ .

To solve the problem of drift two solutions were suggested. One was to make the FPGA calibrate the bias sufficiently often. But since the drift was so slow, and it seemed to stabilize it seemed better to have the intensity modulator permanently biased. Hence, a battery powered biasing circuit was built. See section 3.3.1 for more details on the circuit. This should be sufficient to perform QKD. If however, the drift still is too large and it leads to a security issue, the first solution may be implemented at a later time.<sup>2</sup> Still the permanent bias will be in effect as it gives a good working point for the bias.

 $<sup>^2 {\</sup>rm The}$  method shown in figure 3.6 is a good way to do calibration.

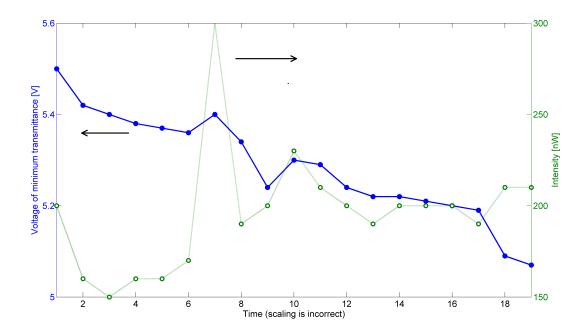


Figure 5.1: Intensity modulator minimum  $\mathbf{V}_{bias}$  drift

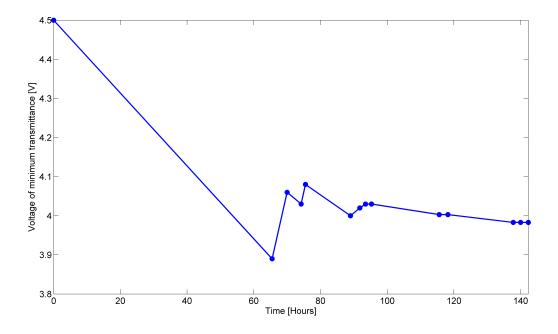


Figure 5.2: Intensity modulator  $V_{bias}$  long term drift

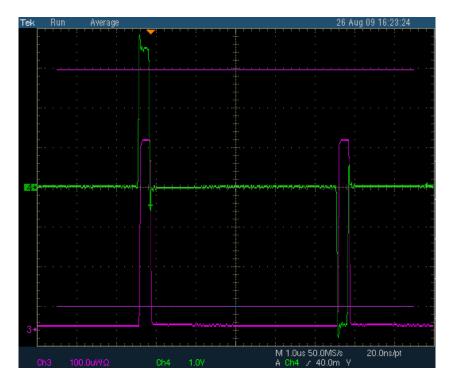


Figure 5.3: Intensity modulation. The green/upper curve shows the input voltage while the purple/lower curve shows the output intensity. For subsequent voltage pulses, the intensity should be the same.

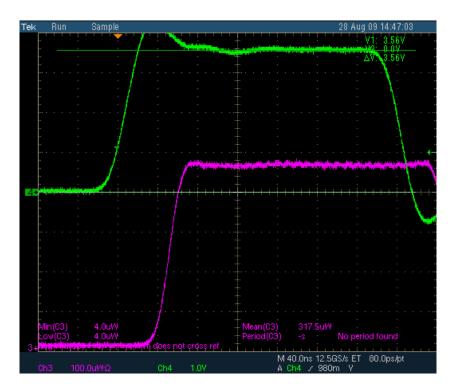


Figure 5.4: Intensity modulator: Zoom-in on pulse. Close-up of one pulse. The intensity (purple/lower) should be a square pulse.

#### 5.2.2 Temperature dependent drifts

While running biased close to  $V_{\mathcal{T}min}$ , the temperature of the intensity modulator was varied with a hot air gun. It showed no variations in intensity modulation as in figure 5.3 in the range of 22°C - 49°C. Hence, neither  $V_{\mathcal{T}min}$  nor  $V_{\pi}$  changed. Also the intensity modulator is thermally connected to the aluminum bulkhead and will therefore have little temperature variations.

### 5.3 Laser

#### Method

The laser, described in section 3.2, was prepared by Ulianov [17]. He constructed a laser driving circuit as described in section 3.2.1. It has an input  $V_S$  (see figure B.1) which, when biased, controls the pulse shape. The pulse was measured using an optical probe with both the DO and the SO. The DO was used because it is easier to handle, and it has the capability to easily take screenshots. However, its bandwidth is limited to 1 GHz, so it could not handle 100 ps pulses which requires about 10 GHz bandwidth to get good pictures. Therefore the SO was used when looking at single pulses. Measurements were done using an extra clock output from the FPGA to trigger the oscilloscopes. Screenshots from the SO were made by using a camera.

The SO was connected to a box made by [13] with a circuit based on a PIN<sup>3</sup> photo diode<sup>4</sup> and an amplifier<sup>5</sup> [13]. It has bandwidth of at least 5 GHz bandwidth. For spectrum analysis the OSA was used. Datafiles were extracted and plotted in Matlab.

#### Results and discussion

Different values of  $V_S$  ranging from -3 V to +3 V were applied. Previous work indicated that the voltage should be close to 0 V [17]. After tuning the voltage through the range, the wanted pulse shape was obtained at low values of -0.1 V to -0.2 V. When the  $V_S$  was higher than this (closer to zero), the pulse collapsed and became extremely unstable. When the voltage was lower than this, the pulse length and amplitude increased. At some point, secondary pulses appeared, as explained in section 3.2. This lead to the construction of a tunable negative voltage supply (appendix B.3).

Figures 5.5 to 5.8 show oscillograms of the laser output. The reason why they have a negative deflection from a stable bias, is that the high-speed photodetector has negative output signal polarity. In figures 5.5 and 5.6 we see that there is one large pulse, followed by a series of decreasing oscillations. These oscillation may originate in the laser, or in

<sup>&</sup>lt;sup>3</sup>PIN - p-type/intrinsic/n-type semiconductor.

<sup>&</sup>lt;sup>4</sup>Hewlet-Packard PDT0313-FC-A.

<sup>&</sup>lt;sup>5</sup>MITEQ AFS4-00101800-43-10P-4.

the high speed photodetector. Since circuit shuts down the laser very quickly, the latter is most probable. In figures 5.7 and 5.8 we see one pulse in averaging mode and running mode respectively. The jitter we see on the latter, is the oscilloscope triggering jitter, and not the laser. This is the 100 ps pulse shape which was wanted. However, PIN diode and amplifier circuit may not have the required bandwidth. It is below 10 GHz, and without knowing the exact value, may be as low as 5-6 GHz. So the 100 ps pulse may be the minimum pulse length the photodetector can measure, and thus the real pulse may be shorter.

In figures 5.9 and 5.10 we see the spectrum of the laser in both continuous and pulsed mode. As we see the laser has a much wider bandwidth in pulsed mode. Theoretical calculation (appendix A.2) of the bandwidth of a 100 ps pulse suggests a bandwidth of only 71 pm, which is in the about the same as the OSA's resolution bandwidth of 60 pm. Still the bandwidth is about 600 pm FWHM. This may suggest that the pulse is actually much shorter than 100 ps, or the bandwidth may be widened due to some effect in the laser. There is as small bump to the right of the main curve of the pulsed mode which suggest that there is another weakly excited longitudinal mode.

The pulsed mode is also shifted down in wavelength (up in frequency) relative to continuous mode. In pulsed mode, the TEC was operational, while in continuous mode it was not. So there may have been a difference in temperature. In future experiments the temperature will tuned, so that hopefully only one mode is present.

Figures 5.11 and 5.12 are single-shot oscillograms of a pulse train. They show that the pulse height varies with time. These are worst case single shots, but it shows that the laser is instable. Although most pulses had the correct shape and amplitude, several did not. It was somewhat affected by the biasing voltage  $V_S$ , but as this also controls the pulse shape, the tuning range was very limited. Debugging this problem was postponed to after this project as it may take much time. The instability may lead to a security issue if Eve is able to exploit it, but the achieved pulsed laser operation should be sufficient to perform a QKD experiment.

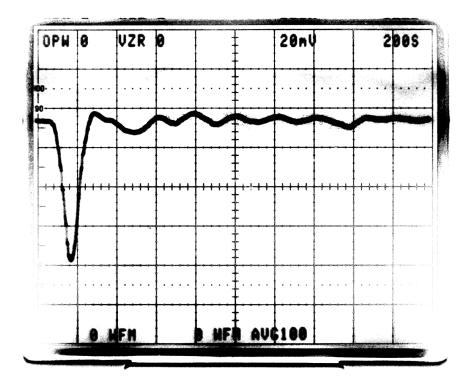


Figure 5.5: Laser pulse, 200ps/div, averaging over 100 sweeps.

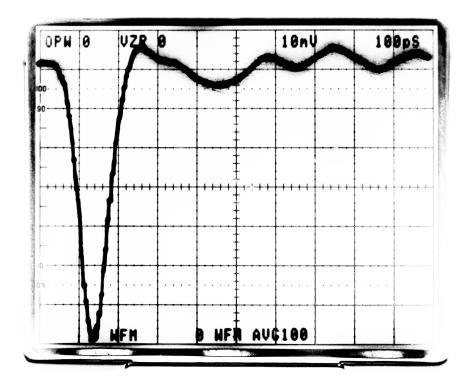


Figure 5.6: Laser pulse, 100ps/div, averaging over 100 sweeps.

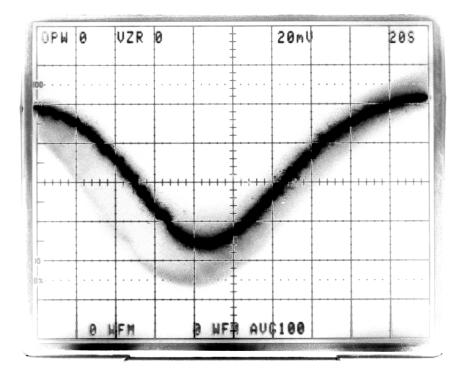


Figure 5.7: Laser pulse, 20 ps/div, averaging over 100 sweeps.

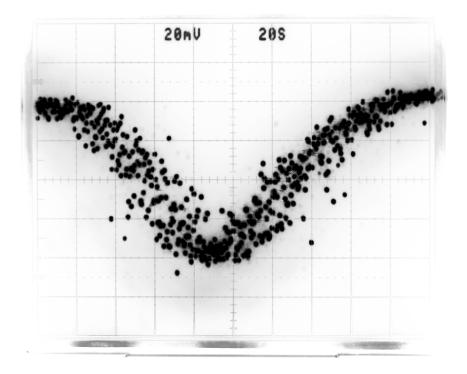


Figure 5.8: Laser pulse, 20ps/div, running mode,  $1/40\mathrm{s}$  shutter

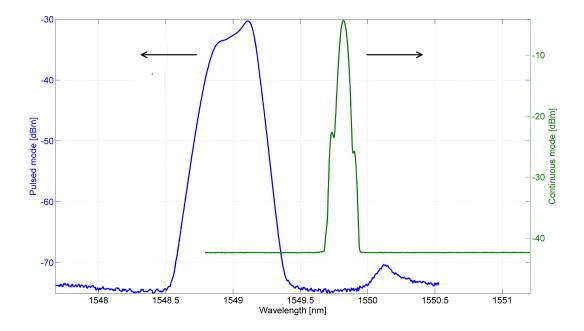


Figure 5.9: Laser spectrum in continuous vs. pulsed mode. Image a resolution is 0.0025 nm. Bandwidth resolution is 0.06 nm, absolute accuracy of the OSA is  $\pm 0.5$ nm.

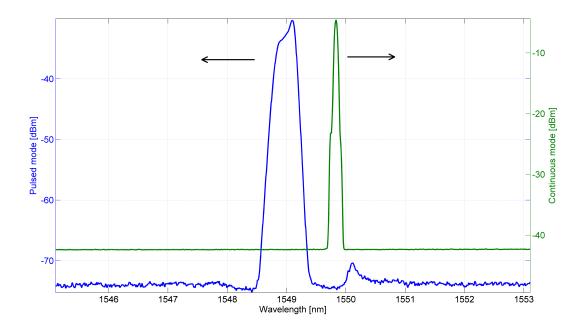


Figure 5.10: Laser spectrum in continuous vs. pulsed mode. Image resolution is 0.0080 nm. Bandwidth resolution is 0.06 nm, absolute accuracy of the OSA is  $\pm 0.5$ nm.

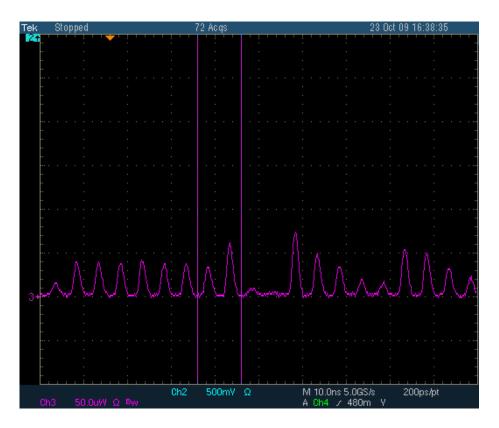


Figure 5.11: Unstable laser pulses

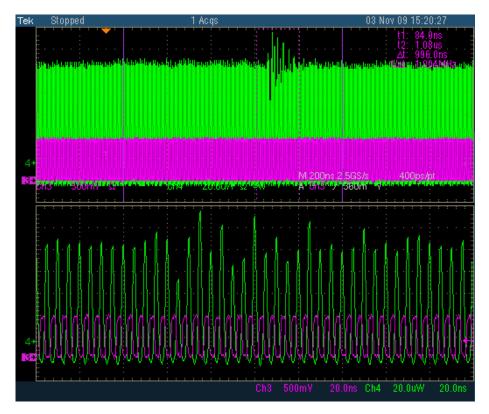


Figure 5.12: Laser instability

# Chapter 6 Conclusion and further work

The goal of building this QKD system is to address all known loopholes. One of them is the PNS attack. It is made possible by the laser source, and has motivated a specific countermeasure implemented for this system; the intensity modulator which controls the level of the signal and decoy pulses.

The intensity modulator which controls the intensity of the pulses showed a time dependent drift in the biasing voltage. This, however, was also dependent on the value of the biasing voltage, and seemed to settle after some time (a few days). This motivated the construction of a battery powered biasing circuit, which supplies the bias input of the intensity modulator with permanent voltage for years. It also has the capability to adjust the voltage for manual calibration.

The laser proved to be more challenging. This was due to the very high frequencies the laser driver had to cope with to create the short 100 ps pulses at 200 MHz repetition rate. Through some fiddling with the connecting coaxial cables and SRD bias voltage, the laser was made to work. Still the laser was not completely stable, showing several short periods of varying pulse height every second. However, it should be sufficient to do QKD experiments as the large majority of pulses were proper.

These components, in addition to electronics, were mounted onto an aluminum bulkhead which will be mounted in Alice's rack case. Together with Bob, and two computers, this will form a complete QKD system which will be used for experiments and demonstration.

As building this QKD system is an ongoing project, the continuation will be in future projects and Master theses. The next step is to assemble Alice's and Bob's interferometer on an optical table and make it work. After that it also has to be mounted in their rack cases. Equivalently, Bob will be built in the same manner, exchanging the source (laser and intensity modulator) with single photon detectors. Then work can proceed to do QKD experiments, and then try to hack this QKD system and discover flaws which can lead to security threats. Security of this system will also be subject to theoretical work. The security will need to be proved, and so the system has to be characterized thoroughly, so its parameters can fit into security proofs.



# Appendix A

# Calculations

# A.1 Derivation of deviation in transmittance for small bias deviation

Inserting  $V_{\mathcal{T}min} + \Delta V$  into equation (3.2) for  $V_{bias}$  and  $V_{RF} = \pm \frac{1}{2} V_{\pi}$ ;  $V = \pm \frac{1}{2} V_{\pi} + V_{bias} + \Delta V$ , we get

$$\mathcal{T}_{\pm}(\Delta V) = \cos^{2}\left(\frac{\varphi_{0}}{2} - \frac{\pi}{2}\frac{\pm\frac{1}{2}V_{\pi}}{V_{\pi}} - \frac{\pi}{2}\frac{V_{\mathcal{T}min} + \Delta V}{V_{b\pi}}\right)$$
$$= \cos^{2}\left(\frac{\varphi_{0}}{2} \mp \frac{\pi}{4} - \frac{\pi}{2}\frac{V_{\mathcal{T}min}}{V_{b\pi}} + \frac{\pi}{2}\frac{\Delta V}{V_{b\pi}}\right)$$
$$= \cos^{2}\left(\frac{\pi}{2} \mp \frac{\pi}{4} + \frac{\pi}{2}\frac{\Delta V}{V_{b\pi}}\right)$$
$$= \sin^{2}\left(\frac{\pi}{4} \pm \frac{\pi}{2}\frac{\Delta V}{V_{b\pi}}\right)$$
(A.1)

where  $\pm$  corresponds to  $\pm \frac{1}{2}V_{\pi}$ , and relation of equation (3.3) was used. Using Taylor expansion around  $\frac{\pi}{4}$  to the first order, we get

$$\mathcal{T}_{\pm}(\Delta V) \approx \sin^2\left(\frac{\pi}{4}\right) \pm 2\sin\left(\frac{\pi}{4}\right)\cos\left(\frac{\pi}{4}\right)\frac{\pi}{2}\frac{\Delta V}{V_{b\pi}}$$

$$= \frac{1}{2} \pm \frac{\pi}{2}\frac{\Delta V}{V_{b\pi}}$$
(A.2)

for small  $\Delta V$ . So we get a  $\Delta T$ 

$$\Delta \mathcal{T}(\Delta V) \approx \frac{\pi}{2} \frac{\Delta V}{V_{b\pi}} \tag{A.3}$$

## A.2 Laser bandwidth

This calculations are based on the assumption that the laser truly gives a single wavelength, and that the modulation is a Gaussian pulse, giving a Gaussian frequency spectrum.

Having the Gaussian function

$$f(t) = e^{-at^2} \tag{A.4}$$

setting  $f(t) = \frac{1}{2}$ , we get

$$a = \frac{\ln 2}{t^2} \tag{A.5}$$

The Fourier transform of (A.4) is

$$F(\omega) = \sqrt{\frac{\pi}{a}} e^{-\omega^2/4a} \tag{A.6}$$

were  $\omega = 2\pi\nu$ . Setting  $F(\omega) = \frac{1}{2}\sqrt{\frac{\pi}{a}}$ , we get

$$\omega = \sqrt{4a\ln 2} = \frac{2\ln 2}{t} \tag{A.7}$$

using FWHM for  $\Delta t$ , we set  $t = \frac{\Delta t}{2}$  and get the bandwidth B

$$B = \frac{\omega}{2\pi} = \frac{2\ln 2}{\pi\Delta t} \approx \frac{0.44}{\Delta t} \tag{A.8}$$

Using FWHM for  $\Delta \nu$ :  $\Delta \nu = 2B$ , we get

$$\Delta \nu = 2 \frac{2 \ln 2}{\pi \Delta t} \approx \frac{0.88}{\Delta t} \tag{A.9}$$

Wavelength is given by

$$\nu = \frac{c}{\lambda} \tag{A.10}$$

Taking the derivative

$$\frac{d\nu}{d\lambda} = -\frac{c}{\lambda^2} \tag{A.11}$$

gives an expression for the spectral width as wavelength

$$\Delta \lambda = \frac{\lambda_0^2}{c} \Delta \nu = \frac{\lambda_0^2}{c} \frac{2\ln 2}{\pi \Delta t}$$
(A.12)

where  $\lambda_0$  is the center wavelength, and  $\Delta t$  is the pulse length. Setting  $\Delta = 100$  ps and  $\lambda_0 = 1550$  nm, we get

 $\Delta \lambda = 7.0726 \cdot 10^{-11} \text{ m} \approx 71 \text{ pm}$  (A.13)

From (A.8) we get  $B \approx 4.4$  GHz, with pulse a length  $\Delta t = 100$  ps.

# Appendix B

# Circuit designs and drawings

## B.1 Laser driver

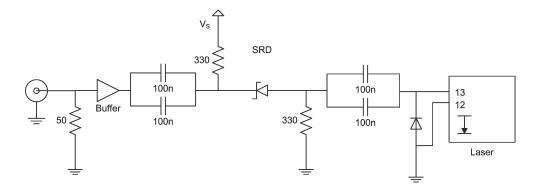


Figure B.1: Laser driver

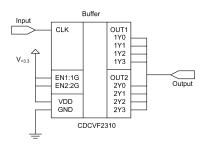


Figure B.2: Buffer

## B.2 Thermoelectric controller

	MAX1968	3 Evaluation Kit	
4	VDD	(TEC+)	TEC+
V <sub>+5.0</sub>	GND	(TEC-)	
		THERM	
-			

Figure B.3: 7	Thermoelectric	controller
---------------	----------------	------------

Max values	Laser	Targeted	Measured
$V_{\text{HEAT}}[V]$	2.5	2.4	2.38
$V_{COOL}[V]$	2.5	2.4	2.41
$I_{\text{HEAT}}[A]$	0.9	0.4	0.30
$I_{COOL}[A]$	1.4	1.0	1.01

Table B.1: TEC-limits

V <sub>MAX</sub>	R2	$15 \mathrm{k}\Omega$	R3	$10 \mathrm{k}\Omega$	$\frac{R3}{R2+R3}4 \cdot 1.5V$
$I_{HEAT}$	R4	$68 \mathrm{k}\Omega$	R6	$10 \mathrm{k}\Omega$	$\frac{R5}{R4+R5}3A$
$I_{COOL}$	R6	$68 \mathrm{k}\Omega$	R7	$33 \mathrm{k}\Omega$	$\frac{R7}{R6+R7}3A$

Table B.2: TEC resistor values

## B.3 Power

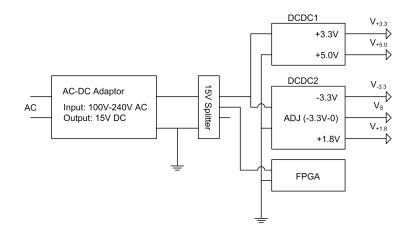


Figure B.4: Power distribution

Voltage output	Used by
V <sub>+3.3</sub>	Buffer
$V_{+5.0}$	TEC
$V_{-3.3}$	unused
$V_S$	Laser driver
$V_{+1.8}$	DAC?
+15	FPGA

Table B.3: Power distribution

# Appendix C

# Datasheets

This appendix contains relevant parts of the following datasheets:

- C.1: Intensity modulator SDL IOAP-MOD 9082 page 44
- C.2: Laser *Eudyma FLD5F15CX-E* page 49
- C.3: Buffer *Texas Instruments CDCVF2310* page 57

## C.1 Intensity modulator

# SDL IOAP-MOD 9082

#### POWERING OPTICAL COMMUNICATIONS

# 10AP-MOD 9082



#### **FEATURES**

- Zero chirp to minimise chromatic dispersion
- True hermetic to Telcordia™ GR-468-CORE
- High on/off extinction ratio
- Wavelength insensitive for high channel count systems

#### **APPLICATIONS**

• Ideal for OC48 applications

## OC48 2.5Gb/s amplitude modulator

he SDL 2.5Gb/s modulator has been designed to exceed the requirements of OC48. Supplied in a hermetic package and

qualified to Telcordia GR-468-CORE, this product ensures high reliability and performance at all times.



#### **IOAP-MOD9082 SPECIFICATIONS**

#### **Electro-Optical Performance**

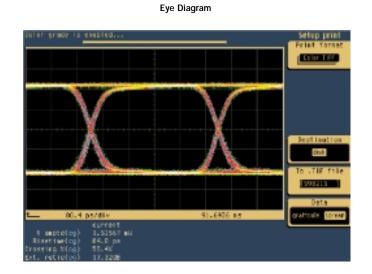
Parameter		Value		Units	
	Min	Тур	Max		
Optical					
Operating Wavelength	1525		1580	nm	
Insertion Loss	2.5	3.8	5.5	dB	
On/off Extinction Ratio (DC)	20	-	-	dB	
Optical Return Loss	-	-	-45	dB	
Electrical					
RF Port					
Chirp	-	0 ±0.2	-	see note 1	
S11 Return Loss (0.13 - 2.5 GHz)	-	-	-8	dB	
Vpi (at 2.5Gb/s PRBS into 50 $\Omega$ )	-	4.2	4.7	V	
Extinction Ratio (at 2.5Gb/s PRBS)	13.0		-	dB	
Rise/Fall Time (10%/90%)	-	-	120	ps	
Parameter	Specificati	on			
Fiber					
Input	Fujikura SN	N-15-P-8/125	-UV/UV-400		
Output	Corning SMF-28				

Qualification & Reliability	True hermetic to GR-468-CORE	
Operating Temperature	0°C to 70°C	
Storage Temperature	-40°C to 80°C	

#### Notes

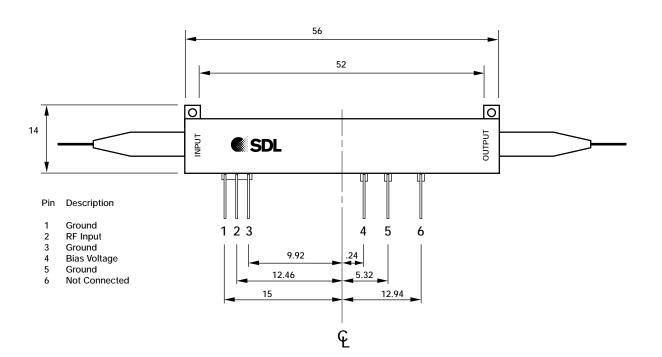
1. Other chirp values are available on a custom basis.

#### Performance



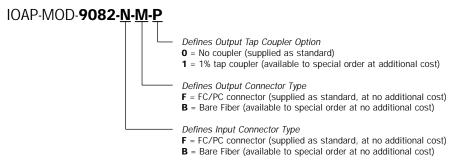
#### **Outline Drawing**

Dimensions in millimeters except where indicated



#### **Ordering Information**

Part Numbers & Options



Default part number is IOAP-MOD-9082-F-F-0 (modulators)



SDL, Inc. 80 Rose Orchard Way San Jose, CA 95134-1365 Tel: 408-943-9411 Fax: 408-943-1430 E-mail: sales@sdll.com SDL Integrated Optics Ltd. 3-4 Waterside Business Park Eastways, Witham, Essex CM8 3YQ, United Kingdom Tel: +44 1376 502110 Fax: +44 1376 502125 E-mail: sdliosales@sdli.com And for the latest information on all SDL products please visit our web site:

## www.sdli.com

All statements, technical information and recommendations related to the products herein are based upon information believed to be reliable or accurate. However, the accuracy or completeness thereof is not guaranteed, and no responsibility is assumed for any inaccuracies. The user assumes all risks and liability whatsoever in connection with the use of a product or its application. SDL reserves the right to change at any time without notice the design, specifications, function, fit or form of its products described herein, including withdraw at any time of a product herein as offered for sale. SDL makes no representations that the products herein are free from any intellectual property claims of others.

C.2 Laser

# Eudyna FLD5F15CX-E

# *1,550nm DWDM Direct Modulation DFB Laser*

## FEATURES

- Direct Modulation Laser for WDM systems
- Optimized for Long Distance Transmission (Dispersion 1800ps/nm)
- Peak wavelength 1527.99 to 1563.05nm (C-band: 191.8 to 196.2THz, 100GHz spacing)
- Output Power: 2mW
- 14-pin Butterfly type package
- Built-in Optical Isolator, Power Monitor PIN-PD, Thermistor, and Cooler
- Single Mode Fiber

## **APPLICATIONS**

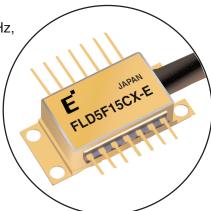
This laser is intended for the application of 2.5 Gb/s long haul Dense Wavelength Division Multiplexing (DWDM). Transmission spans of 100km (1800ps/nm) are possible.

### DESCRIPTION

The laser is capable of 2.5 Gb/s transmission. It is packaged in a "butterfly" type module. The module employs a highly stable optical coupling system, coupling the laser output through a built-in optical isolator into a single mode fiber pigtail. The module also includes a monitor photodiode, a thermoelectric cooler (TEC), and thermistor. This device is designed for use in DWDM direct modulation transmission systems. Selected wavelengths specified to the ITU-T grid are available.

#### ABSOLUTE MAXIMUM RATINGS (Tc=25°C, unless otherwise specified)

Devenueter	Cumhal	Condition	Rat	tings	Unit
Parameter	Symbol	Condition	Min.	Max.	Unit
Storage Temperature	T <sub>stg</sub>	-	-40	+85	°C
Operating Case Temperature	Т <sub>ор</sub>	-	-20	+70	°C
Optical Output Power	Pf	CW	-	5	mW
LD Forward Current	١F	CW	-	150	mA
LD Reverse Voltage	VR	-	-	2	V
PD Reverse Voltage	VDR	-	-	20	V
PD Forward Current	IPF	-	-	10	mA
Cooler Voltage	V <sub>c</sub>	Cooling	-	2.5	v
		Heating	-2.5	-	
Cooler Current		Cooling	-	1.4	A
Cooler Current	۱ <sub>C</sub>	Heating	-0.9	-	
Thermistor Temperature	T <sub>th</sub>	ATC Operation	-20	+70	°C
Lead Soldering Time	T <sub>sold</sub>	260°C	-	10	sec
Environmental Operating Humidity	Х <sub>ор</sub>	Top<30°C	-	95	%
Environmental Storage Humidity	X <sub>st</sub>	Tstg<30°C	-	95	%





# FLD5F15CX-E-

## 1,550nm DWDM Direct Modulation DFB Laser

#### OPTICAL AND ELECTRICAL CHARACTERISTICS (TL=Tset, Tc=25°C, BOL, unless otherwise specified)

Deversator	Cumphed	Test Canditions		Limits		
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Laser Set Temperature	⊤ <sub>set</sub>	-	20	-	35	°C
Threshold Current	lth	CW	4	-	40	mA
Forward Voltage	VFDC	CW, I <sub>F</sub> =30 mA, pin 12, 13	-	1.6	1.75	V
Series Resistance	Rs	CW, pin 12, 13	22	25	28	Ω
Optical Output Power	Pf	CW	2.0	-	-	mW
Slope Efficiency	η	CW, Pf=2mW	0.03	0.04	-	mW/mA
Threshold Power	Pth	I <sub>F</sub> =I <sub>th</sub> , CW	-	-	150	μW
Tracking Error (Note 1)	TE	Pf=2mW, T <sub>C</sub> =-20 to 70°C, Im-APC	-0.5	-	+0.5	dB
Monitor Current	۱ <sub>m</sub>	CW, Pf=2mW, V <sub>DR</sub> =5V	0.25	-	2.0	mA
Photodiode Dark Current	ID	V <sub>DR</sub> =5V	-	2	100	nA
Photodiode Capacitance	Ct	V <sub>DR</sub> =5V, f=1 MHz	-	-	10	pF
Photodiode Cutoff Frequency	fcm	$V_{DR}$ =5V, 50 $\Omega$ load	100	-	-	MHz
Peak Wavelength	λp	Note (2)	Note (4)			nm
Wavelength Drift (after 20 yrs)	Δλ	Note (2)	-100	-	+100	pm
Wavelength Stabilty with Case Temperature	dλ/dTc	Tc=-20 to 70°C	-1.0	-	+1.0	pm/°C
Side Mode Suppression	Sr	Note (2)	35	40	-	dB
Spectral Width (-20dB)	δλ	Note (2)	-	-	0.5	nm
Rise/Fall Time	T <sub>r,</sub> T <sub>f</sub>	20% to 80%	-	-	0.125	nsec
Cutoff Frequency	f <sub>C</sub>	P <sub>f</sub> =2mW, -3 dB	3.5	-	-	GHz
		f=50 MHz ~ 2 GHz	8	-	-	dB
RF Return Loss	S11	f=2 GHz ~ 3 GHz	6	-	-	dB
		f=3 GHz ~ 5 GHz	3	-	-	dB
Optical Isolation	ا <sub>S</sub>	Tc=-20 to 70°C	25	35	-	dB
Relative Intensity Noise	RIN	f=2.5 GHz Pf=2mW, ORL=24 dB	-	-	-140	dB/Hz
Kink	Kns	up to 2.4mW		No Kink		-
Dispersion Penalty	dP	Note (3)	-	-	2.0	dB

Note 1. TE=10\*log{pf(Tcase)/Pf(Tc=25°C)}(dB)

Note 2. 2.5 Gb/s NRZ, Ppeak=2mW, Rext=8.2dB, PRBS=2<sup>23</sup>-1,

Note 3. Bit rate=2.48832 Gb/s, PRBS=2<sup>23</sup>-1, Dispersion=1,800 ps/nm, Ppeak=2mW,

Rext=8.2dB Decision point: Center of Back-to-Back at 10<sup>-9</sup>, No Floor, Receiver: Eudyna Standard Receiver

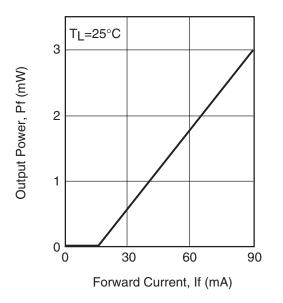
Note 4. The selected wavelengths available are listed in Fig. 8

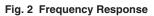


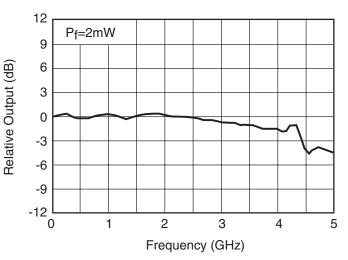
#### TEC AND THERMISTOR CHARACTERISTICS (TL=Tset, Tc=25°C, BOL, unless otherwise specified)

Parameter	Cumbal	Test Conditions		Limit	Unit	
Parameter	Symbol Test Conditions		Min.	Тур.	Max.	Unit
Cooler Current	۱ <sub>c</sub>		-	-	1.0	А
Cooler Voltage	Vc	TL=Tset, Pf=2mW, Tc=70°C	-	-	2.4	V
Cooler Power	Pc	1 ,	-	-	2.4	W
Thermistor Resistance	Rtr	TL=25°C	9.5	10.0	10.5	kΩ
Thermistor B Constant	В		3,270	3,450	3,630	K

Fig. 1 Forward Current vs Output Power







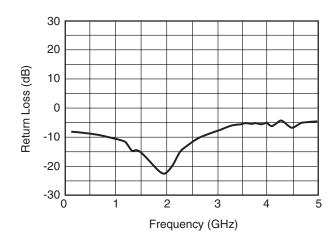


# FLD5F15CX-E-

## 1,550nm DWDM Direct Modulation DFB Laser

#### Fig. 3 RF Return Loss

#### Fig. 4 Cooler Voltage -Current



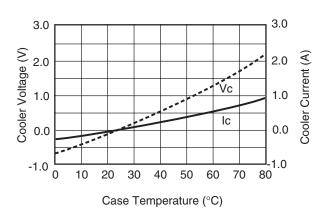


Fig. 5 Spectrum

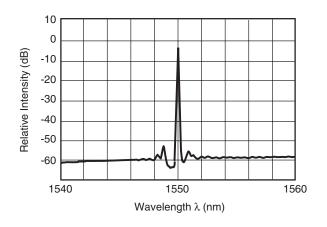
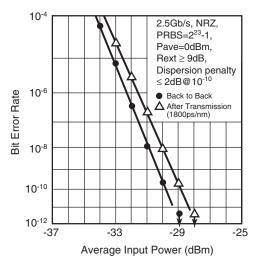


Fig. 6 Temperature Dependance of Wavelength (ACC Operation)

# Eudyna

## *1,550nm DWDM Direct Modulation DFB Laser*

# FLD5F15CX-E



#### Fig. 7 Transmission Characteristics

#### Fig. 8 Wavelength Table

		1
	Wavelength (nm)	
Part Number	(TL=Tset)	Tolerance (nm)
	(in vacuum)	
FLD5F15CX-E9620	1527.99	±0.1
-E9610	1528.77	±0.1
-E9600	1529.55	±0.1
-E9590	1530.33	±0.1
-E9580	1531.12	±0.1
-E9570	1531.90	±0.1
-E9560	1532.68	±0.1
-E9550	1533.47	±0.1
-E9540	1534.25	±0.1
-E9530	1535.04	±0.1
-E9520	1535.82	±0.1
-E9510	1536.61	±0.1
-E9500	1537.40	±0.1
-E9490	1538.19	±0.1
-E9480	1538.98	±0.1
-E9470	1539.77	±0.1
-E9460	1540.56	±0.1
-E9450	1541.35	±0.1
-E9440	1542.14	±0.1
-E9430	1542.94	±0.1
-E9420	1543.73	±0.1

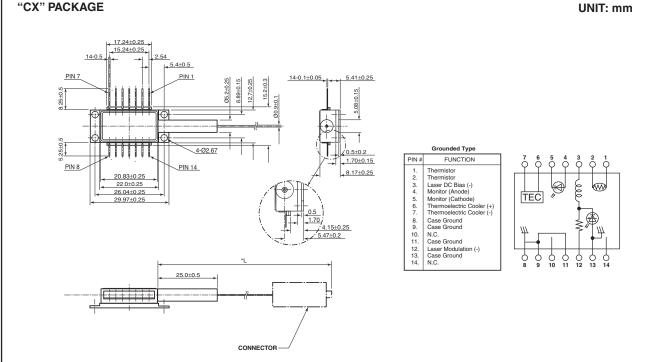
-E9410	1544.53	±0.1
-E9400	1545.32	±0.1
-E9390	1546.12	±0.1
-E9380	1546.92	±0.1
-E9370	1547.72	±0.1
-E9360	1548.51	±0.1
-E9350	1549.32	±0.1
-E9340	1550.12	±0.1
-E9330	1550.92	±0.1
-E9320	1551.72	±0.1
-E9310	1552.52	±0.1
-E9300	1553.33	±0.1
-E9290	1554.13	±0.1
-E9280	1554.94	±0.1
-E9270	1555.75	±0.1
-E9260	1556.55	±0.1
-E9250	1557.36	±0.1
-E9240	1558.17	±0.1
-E9230	1558.98	±0.1
-E9220	1559.79	±0.1
-E9210	1560.61	±0.1
-E9200	1561.42	±0.1
-E9190	1562.23	±0.1
-E9180	1563.05	±0.1



# FLD5F15CX-E

## 1,550nm DWDM Direct Modulation DFB Laser

"CX" PACKAGE



#### For further information please contact:

#### Eudyna Devices USA Inc.

2355 Zanker Rd. San Jose, CA 95131-1138, U.S.A. TEL: (408) 232-9500 FAX: (408) 428-9111 www.us.eudyna.com

#### Eudyna Devices Europe Ltd.

**Network House** Norreys Drive Maidenhead, Berkshire SL6 4FJ United Kingdom TEL: +44 (0) 1628 504800 FAX: +44 (0) 1628 504888

#### Eudyna Devices Asia Pte Ltd. Hong Kong Branch

Rm. 1101, Ocean Centre, 5 Canton Rd. Tsim Sha Tsui, Kowloon, Hong Kong TEL: +852-2377-0227 FAX: +852-2377-3921

#### Eudyna Devices Inc.

Sales Division 1, Kanai-cho, Sakae-ku Yokohama, 244-0845, Japan TEL: +81-45-853-8156 FAX: +81-45-853-8170

#### CAUTION

Eudyna Devices Inc. products contain gallium arsenide (GaAs) which can be hazardous to the human body and the environment. For safety, observe the following procedures:

• Do not put this product into the mouth.

- Do not alter the form of this product into a gas, powder, or liquid through burning, crushing, or chemical processing as these by-products are dangerous to the human body if inhaled, ingested, or swallowed.
- · Observe government laws and company regulations when discarding this product. This product must be discarded in accordance with methods specified by applicable hazardous waste procedures.

Eudyna Devices Inc. reserves the right to change products and specifications without notice. The information does not convey any license under rights of Eudyna Devices Inc. or others.

© 2004 Eudyna Devices USA Inc. Printed in U.S.A.



### *FLD5F15CX-E9340*

Tested by ; S. Watanabe

ITEM		CONDITION.	S(TLD=27. 73℃)	LINIT	VALUE	UNIT
Threshold Current	Ith	C₩		4.0~40.0	13.6	шA
Operating Current	Iop	<i>С₩</i>	Pf=2mW		55.2	mА
Slope Efficiency	S	C₩	Pf=2mW	0.030 min	0. 048	W/A
Monitor Detector Current	Im	C₩	P1=2mW	0. 250~2. 000	0. 717	mA
Peak Wavelength	λρ	Note		1550.02~1550.22	1550.12	nm
Thermistor Set Resistance	Rset	Tth=Tset		6.87~12.18	9.00	kΩ

Note : 2. 48832Gb/s, NRZ, PRBS2 23-1, Ppeak=2mW, Rex=8. 2dB

CAUTION ! Use of control or adjustment or performance of procedures

other than those specified herein may result in hazardous radiation exposure.

Eudyna Devices Inc.

## C.3 Buffer IC

# Texas Instruments CDCVF2310



#### **CDCVF2310**

SCAS666C-JUNE 2001-REVISED JANUARY 2008

24

23

22

21

20

19

18

17

16

15

14

13

1 2Y0

□ 2Y1

🗖 GND

🗖 GND

🗖 2Y2

🗖 2Y3

סס ע

T V<sub>DD</sub>

🗖 2G

**PW PACKAGE** 

(TOP VIEW)

 $\cap$ 

1

2

3

4

5

6

7

8

9

10

11

12

GND 🗖

V<sub>DD</sub>

1Y0 🗖

1Y1 🗖

1Y2 🗖

GND

GND

1Y3 🗖

1Y4 🗖

V<sub>DD</sub>

1G 🗖

2Y4 🗖

### 2.5-V TO 3.3-V HIGH-PERFORMANCE CLOCK BUFFER

#### FEATURES

- High-Performance 1:10 Clock Driver
- Operates up to 200 MHz at V<sub>DD</sub> 3.3 V
- Pin-to-Pin Skew < 100 ps at V<sub>DD</sub> 3.3 V
- V<sub>DD</sub> Range: 2.3 V to 3.6 V
- Operating Temperature Range –40°C to 85°C
- Output Enable Glitch Suppression
- Distributes One Clock Input to Two Banks of Five Outputs
- 25-Ω On-Chip Series Damping Resistors
- Packaged in 24-Pin TSSOP

#### **APPLICATIONS**

General-Purpose Applications

#### DESCRIPTION

The CDCVF2310 is a high-performance, low-skew clock buffer that operates up to 200 MHz. Two banks of five outputs each provide low-skew copies of CLK. After power up, the default state of the outputs is low regardless of the state of the control pins. For normal operation, the outputs of bank 1Y[0:4] or 2Y[0:4] can be placed in a low state when the control pins (1G or 2G, respectively) are held low and a negative clock edge is detected on the CLK input. The outputs of bank 1Y[0:4] or 2Y[0:4] can be switched into the buffer mode when the control pins (1G and 2G) are held high and a negative clock edge is detected on the CLK input. The device operates in a 2.5-V and 3.3-V environment. The built-in output enable glitch suppression ensures a synchronized output enable sequence to distribute full period clock signals.

The CDCVF2310 is characterized for operation from -40°C to 85°C.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

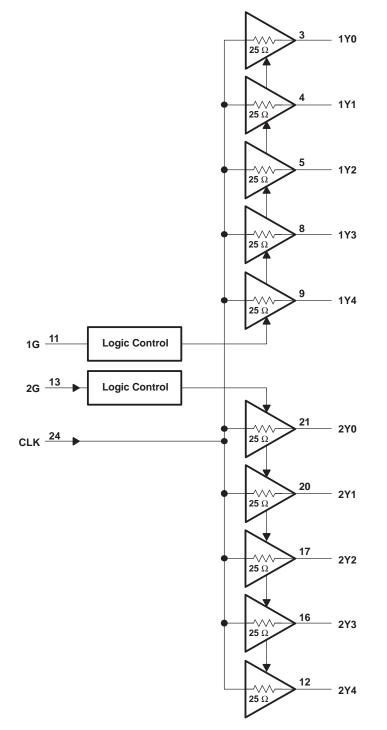
### CDCVF2310

SCAS666C-JUNE 2001-REVISED JANUARY 2008



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### FUNCTIONAL BLOCK DIAGRAM



2



#### SCAS666C-JUNE 2001-REVISED JANUARY 2008

#### FUNCTION TABLE

	INPUT		OUTPUT		
1G	2G	CLK	1Y[0:4]	2Y[0:4]	
L	L	$\downarrow$	L	L	
Н	L	$\downarrow$	CLK <sup>(1)</sup>	L	
L	Н	$\downarrow$	L	CLK <sup>(1)</sup>	
Н	Н	$\downarrow$	CLK <sup>(1)</sup>	CLK <sup>(1)</sup>	

(1) After detecting one negative edge on the CLK input, the output follows the input CLK if the control pin is held high.

#### **Terminal Functions**

	TERMINAL	1/0	DESCRIPTION			
NAME	NO.	- I/O	DESCRIPTION			
1G	11	I	Output enable control for 1Y[0:4] outputs. This output enable is active-high, meaning the 1Y[0:4] clock outputs follow the input clock (CLK) if this pin is logic high.			
2G	13	I	Output enable control for 2Y[0:4] outputs. This output enable is active-high, meaning the 2Y[0:4] clock outputs follow the input clock (CLK) if this pin is logic high.			
1Y[0:4]	3, 4, 5, 8, 9	0	Buffered output clocks			
2Y[0:4]	21, 20, 17, 16, 12	0	Buffered output clocks			
CLK	24	I	Input reference frequency			
GND	1, 6, 7, 18, 19		Ground			
V <sub>DD</sub>	2, 10, 14, 15, 22, 23		DC power supply, 2.3 V – 3.6 V			

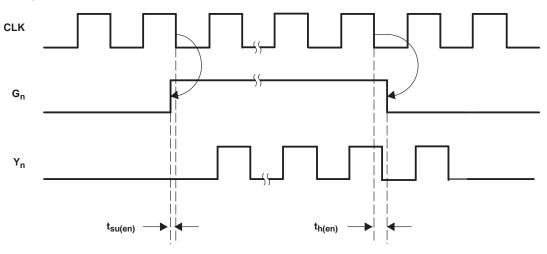


#### DETAILED DESCRIPTION

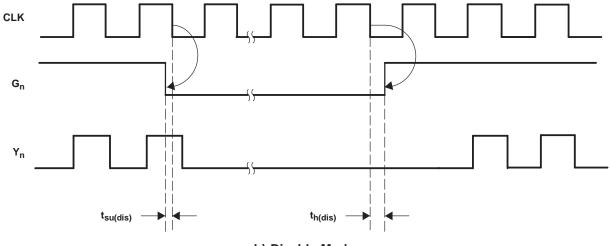
#### **Output Enable Glitch Suppression Circuit**

The purpose of the glitch suppression circuitry is to ensure the output enable sequence is synchronized with the clock input such that the output buffer is enabled or disabled on the next full period of the input clock (negative edge triggered by the input clock) (see Figure 1).

The G input must fulfill the timing requirements  $(t_{su}, t_h)$  according to the Switching Characteristics table for predictable operation.



a) Enable Mode



b) Disable Mode

Figure 1. Enable and Disable Mode Relative to  $\text{CLK}{\downarrow}$ 

4

#### **ABSOLUTE MAXIMUM RATINGS**

over operating free-air temperature range (unless otherwise noted) <sup>(1)</sup>

Supply voltage range, V <sub>DD</sub>	–0.5 V to 4.6 V
Input voltage range, V <sub>I</sub> <sup>(2)(3)</sup>	–0.5 V to V <sub>DD</sub> + 0.5 V
Output voltage range, V <sub>O</sub> <sup>(2)(3)</sup>	–0.5 V to V <sub>DD</sub> + 0.5 V
Input clamp current, $I_{IK}$ (V <sub>I</sub> < 0 or V <sub>I</sub> > V <sub>DD</sub> )	±50 mA
Output clamp current, $I_{OK}$ (V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>DD</sub> )	±50 mA
Continuous total output current, $I_O (V_O = 0 \text{ to } V_{DD})$	±50 mA
Package thermal impedance, $\theta_{JA}^{(4)}$ : PW package	120°C/W
Storage temperature range T <sub>stg</sub>	–65°C to 150°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

2) The input and output negative voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

(3) This value is limited to 4.6 V maximum.

(4) The package thermal impedance is calculated in accordance with JESD 51.

#### **RECOMMENDED OPERATING CONDITIONS** <sup>(1)</sup>

		MIN	NOM	MAX	UNIT
ligh-level output current, I <sub>OH</sub>		2.3	2.5		V
Supply voltage, v <sub>DD</sub>			3.3	3.6	v
	V <sub>DD</sub> = 3 V to 3.6 V			0.8	V
Low-level input voltage, vil	$V_{DD} = 2.3 \text{ V to } 2.7 \text{ V}$			0.7	v
High lovel input veltage. V	$V_{DD} = 3 V \text{ to } 3.6 V$	2			V
High-level liput voltage, v <sub>IH</sub>	$V_{DD} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7	2.5           3.3         3.6           0.8	v	
Input voltage, V <sub>I</sub>		0		$V_{DD}$	V
High lovel output ourrent	$V_{DD} = 3 V$ to 3.6 V			12	mA
High-level output current, I <sub>OH</sub>	$V_{DD} = 2.3 \text{ V to } 2.7 \text{ V}$			6	ma
	$V_{DD} = 3 V \text{ to } 3.6 V$			12	~
Low-level output current, I <sub>OL</sub>	V <sub>DD</sub> = 2.3 V to 2.7 V			6	mA
Operating free-air temperature, T	N Contraction of the second se	-40		85	°C

(1) Unused inputs must be held high or low to prevent them from floating.

#### ELECTRICAL CHARACTERISTICS

over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CO	ONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>IK</sub>	Input voltage	$V_{DD} = 3 V,$	I <sub>I</sub> = -18 mA			-1.2	V
I <sub>I</sub>	Input current	$V_{I} = 0 V \text{ or } V_{DD}$				±5	μA
$I_{DD}^{(2)}$	Static device current	$CLK = 0 V \text{ or } V_{DD},$	$I_0 = 0 \text{ mA}$			80	μA
CI	Input capacitance	$V_{DD} = 2.3 \text{ V to } 3.6 \text{ V},$	$V_I = 0 V \text{ or } V_{DD}$		2.5		pF
Co	Output capacitance	V <sub>DD</sub> = 2.3 V to 3.6 V,	$V_{I} = 0 V \text{ or } V_{DD}$		2.8		pF

(1) All typical values are at respective nominal  $V_{DD}$ .

(2) For  $I_{CC}$  over frequency, see Figure 6.

#### $V_{DD} = 3.3 \text{ V} \pm 0.3 \text{ V}$

	PARAMETER	TEST C	CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>OH</sub> High-level output voltage	V <sub>DD</sub> = min to max,	I <sub>OH</sub> = −100 μA	V <sub>DD</sub> - 0.2				
	V - 2 V	I <sub>OH</sub> = -12 mA	2.1			V	
		$V_{DD} = 3 V$	I <sub>OH</sub> = -6 mA	2.4			

(1) All typical values are at respective nominal V<sub>DD</sub>.

Copyright © 2001–2008, Texas Instruments Incorporated



	PARAMETER	TEST	CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT	
		V <sub>DD</sub> = min to max,	I <sub>OL</sub> = -100 μA			0.2		
V <sub>OL</sub>	Low-level output voltage	V - 2 V	I <sub>OL</sub> = 12 mA			0.8	V	
		vDD - 3 v	$V_{DD} = 3 V$	$I_{OL} = 6 \text{ mA}$			0.55	
		V <sub>DD</sub> = 3 V,	V <sub>O</sub> = 1 V	-28				
I <sub>OH</sub>	OH High-level output current	V <sub>DD</sub> = 3.3 V,	V <sub>O</sub> = 1.65 V		-36		mA	
		V <sub>DD</sub> = 3.6 V,	V <sub>O</sub> = 3.135 V			-14		
		$V_{DD} = 3 V,$	V <sub>O</sub> = 1.95 V	28				
I <sub>OL</sub>	Low-level output current	V <sub>DD</sub> = 3.3 V,	V <sub>O</sub> = 1.65 V		36		mA	
		V <sub>DD</sub> = 3.6 V,	$V_0 = 0.4 V$			14		

#### $V_{DD} = 3.3 \text{ V} \pm 0.3 \text{ V}$ (continued)

#### $V_{DD} = 2.5 \text{ V} \pm 0.2 \text{ V}$

	PARAMETER	TEST	CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
V	High lovel output voltage	V <sub>DD</sub> = min to max,	I <sub>OH</sub> = −100 μA	V <sub>DD</sub> - 0.2			V
V <sub>OH</sub>	High-level output voltage	V <sub>DD</sub> = 2.3 V	I <sub>OH</sub> = -6 mA	1.8			v
V	Low lovel output veltage	V <sub>DD</sub> = min to max,	I <sub>OL</sub> = 100 μA			0.2	V
V <sub>OL</sub>	Low-level output voltage	V <sub>DD</sub> = 2.3 V	I <sub>OL</sub> = 6 mA			0.55	v
		V <sub>DD</sub> = 2.3 V,	$V_0 = 1 V$	-17			
I <sub>OH</sub>	High-level output current	V <sub>DD</sub> = 2.5 V,	V <sub>O</sub> = 1.25 V		-25		mA
		V <sub>DD</sub> = 2.7 V,	V <sub>O</sub> = 2.375 V			-10	
		V <sub>DD</sub> = 2.3 V,	V <sub>O</sub> = 1.2 V	17			
I <sub>OL</sub>	Low-level output current	V <sub>DD</sub> = 2.5 V,	V <sub>O</sub> = 1.25 V		25		mA
		V <sub>DD</sub> = 2.7 V,	V <sub>O</sub> = 0.3 V			10	

(1) All typical values are at respective nominal  $V_{\text{DD}}.$ 

#### TIMING REQUIREMENTS

over recommended ranges of supply voltage and operating free-air temperature

			MIN	NOM	MAX	UNIT	
f Clock from		V <sub>DD</sub> = 3 V to 3.6 V	0		200	MHz	Ì
f <sub>clk</sub> Clock free	quency	V <sub>DD</sub> = 2.3 V to 2.7 V	0		170	IVITZ	

#### JITTER CHARACTERISTICS

Characterized using CDCVF2310 Performance EVM when  $V_{DD}$ =3.3 V. Outputs not under test are terminated to 50  $\Omega$ .

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
	Additive phase jitter from input to output 1Y0	12 kHz to 5 MHz, $f_{out}$ = 30.72 MHz		52		fo rmo
ljitter	Additive phase jitter from input to output 140	12 kHz to 20 MHz, $f_{out}$ = 125 MHz		45		fs rms

6



#### SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range (unless otherwise noted)

#### V<sub>DD</sub> = 3.3 V ±0.3 V (see Figure 2)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>PLH</sub> t <sub>PHL</sub>	CLK to Yn	f = 0 MHz to 200 MHz For circuit load, see Figure 2.	1.3		2.8	ns
t <sub>sk(o)</sub>	Output skew (Ym to Yn) <sup>(1)</sup> (see Figure 4)				100	ps
t <sub>sk(p)</sub>	Pulse skew (see Figure 5)				250	ps
t <sub>sk(pp)</sub>	Part-to-part skew				500	ps
t <sub>r</sub>	Rise time (see Figure 3)	$V_0 = 0.4 V \text{ to } 2 V$	0.7		2	V/ns
t <sub>f</sub>	Fall time (see Figure 3)	$V_0 = 2 V \text{ to } 0.4 V$	0.7		2	V/ns
t <sub>su(en)</sub>	Enable setup time, G_high before CLK $\downarrow$		0.1			ns
t <sub>su(dis)</sub>	Disable setup time, G_low before CLK $\downarrow$		0.1			ns
t <sub>h(en)</sub>	Enable hold time, G_high after CLK $\downarrow$		0.4			ns
t <sub>h(dis)</sub>	Disable hold time, G_low after CLK $\downarrow$		0.4			ns

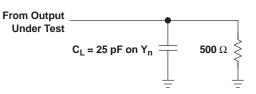
(1) The  $t_{sk(o)}$  specification is only valid for equal loading of all outputs.

#### V<sub>DD</sub> = 2.5 V ±0.2 V (see Figure 2)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>PLH</sub>	CLK to Yn	f = 0 MHz to 170 MHz	1.5		3.5	ns
t <sub>PHL</sub>		For circuit load, see Figure 2.				
t <sub>sk(o)</sub>	Output skew (Ym to Yn) $^{(1)}$ (see Figure 4 )				170	ps
t <sub>sk(p)</sub>	Pulse skew (see Figure 5)				400	ps
t <sub>sk(pp)</sub>	Part-to-part skew				600	ps
t <sub>r</sub>	Rise time (see Figure 3)	$V_{O} = 0.4 \text{ V}$ to 1.7 V	0.5		1.4	V/ns
t <sub>f</sub>	Fall time (see Figure 3)	$V_{O} = 1.7 V \text{ to } 0.4 V$	0.5		1.4	V/ns
t <sub>su(en)</sub>	Enable setup time, G_high before CLK $\downarrow$		0.1			ns
t <sub>su(dis)</sub>	Disable setup time, G_low before CLK $\downarrow$		0.1			ns
t <sub>h(en)</sub>	Enable hold time, G_high after CLK $\downarrow$		0.4			ns
t <sub>h(dis)</sub>	Disable hold time, G_low after CLK $\downarrow$		0.4			ns

(1) The  $t_{sk(o)}$  specification is only valid for equal loading of all outputs.

#### PARAMETER MEASUREMENT INFORMATION



- A. C<sub>L</sub> includes probe and jig capacitance.
- B. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  200 MHz, Z<sub>0</sub> = 50  $\Omega$ ,  $t_r < 1.2$  ns,  $t_f < 1.2$  ns.

#### Figure 2. Test Load Circuit

Copyright © 2001–2008, Texas Instruments Incorporated

#### PARAMETER MEASUREMENT INFORMATION (continued)

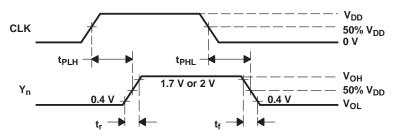
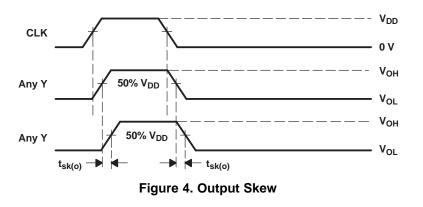
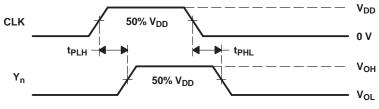


Figure 3. Voltage Waveforms Propagation Delay Times



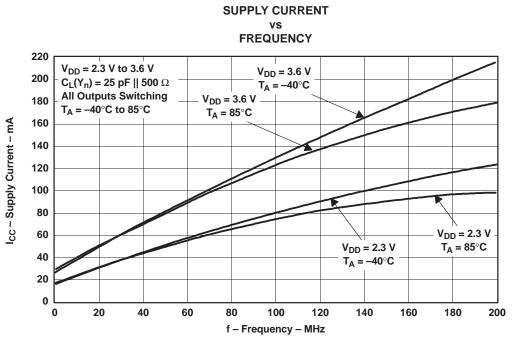


NOTE:  $t_{sk(p)} = |t_{PLH} - t_{PHL}|$ 

Figure 5. Pulse Skew

8





#### PARAMETER MEASUREMENT INFORMATION (continued)

Figure 6.

## References

- C. H. Bennett and G. Brassard. Quantum cryptography: Public key distribution and coin tossing. Proceedings of IEEE International Conference on Computers, Systems, and Signal Processing, pages 175–179, 1984.
- [2] Daniel J. Bernstein, Sean Hallgren, and Ulrich Vollmer. Introduction to post-quantum cryptography, Quantum computing. In Daniel J. Bernstein, Johannes Buchmann, and Erik Dahmen, editors, *Post-Quantum Cryptography*. Springer Berlin Heidelberg, 2009.
- [3] Gilles Brassard, Norbert Lütkenhaus, Tal Mor, and Barry C. Sanders. Limitations on practical quantum cryptography. *Phys. Rev. Lett.*, 85(6):1330–1333, Aug 2000.
- [4] Nicolas Gisin, Grégoire Ribordy, Wolfgang Tittel, and Hugo Zbinden. Quantum cryptography. *Rev. Mod. Phys.*, Sep 2001.
- [5] Ian Glendinning. Front page picture of march 1998 physics world. http://www.vcpc. univie.ac.at/~ian/hotlist/qc/misc/AliceBob.html, November 2009.
- [6] B. Huttner, N. Imoto, N. Gisin, and T. Mor. Quantum cryptography with coherent states. *Phys. Rev. A*, 51(3):1863–1869, Mar 1995.
- [7] Won-Young Hwang. Quantum key distribution with high loss: Toward global secure communication. *Phys. Rev. Lett.*, 91(5):057901, Aug 2003.
- [8] Hoi-Kwong Lo, Xiongfeng Ma, and Kai Chen. Decoy state quantum key distribution. *Phys. Rev. Lett.*, 94(23):230504, Jun 2005.
- [9] Xiongfeng Ma, Bing Qi, Yi Zhao, and Hoi-Kwong Lo. Practical decoy state for quantum key distribution. *Phys. Rev. A*, 72(1):012326, Jul 2005.
- [10] Vadim Makarov. *Quantum cryptography and quantum cryptanalysis*. PhD thesis, Norwegian University of Science and Technology, 2007.
- [11] Robert J. McEliece. A public-key cryptosystem based on algebraic coding theory. Technical report, Jet Propulsion Lab Deep Space Network Progress report, 1978.
- [12] R.S. Moyer, R. Grencavich, R.W. Smith, and W.J. Minford. Design and qualification of hermetically packaged lithium niobate optical modulator. In *Electronic Components* and Technology Conference, 1997. Proceedings., 47th, pages 425–429, May 1997.

- [13] Torbjørn Nesheim. Single photon detection using avalanche photodiode. Master's thesis, Norwegian University of Science and Technology, 1999.
- [14] R. L. Rivest, A. Shamir, and L. Adleman. A method for obtaining digital signatures and public-key cryptosystems. *Commun. ACM*, 21(2):120–126, 1978.
- [15] Bahaa E. A. Saleh and Malvin C. Teich. Fundamentals of Photonics, pages 340– 341,350,463–464,532–620,840–842. Wiley-Interscience, 2nd edition, August 1991.
- [16] Peter W. Shor. Polynomial-time algorithms for prime factorization and discrete logarithms on a quantum computer. *SIAM J.Sci.Statist.Comput.*, 26:1484, 1997.
- [17] Mikhail Ulianov. Quantum key distribution system. Master's thesis, St. Petersburg State Polytechnical University, 2009.
- [18] Lars Vincent van De Wiel Lydersen. Security of qkd-systems with detector efficiency mismatch. Master's thesis, Norwegian University of Science and Technology, 2008.
- [19] Gilbert S. Vernam. Cipher printing telegraph systems for secret wire and radio telegraphic communications. *Journal of the American Institute of Electrical Engineers*, 45:109–115, February 1926.
- [20] W. K. Wootters and W. H. Zurek. A single quantum cannot be cloned. Nature, 299(5886):802–803, October 1982.